

**Characteristics (T<sub>j</sub> = 25°C)**
**Kennwerte (T<sub>j</sub> = 25°C)**

		<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>
Drain-Source breakdown voltage – Drain-Source-Durchbruchspannung I <sub>D</sub> = 100 μA	V <sub>(BR)DSS</sub>	60 V		
Drain-Source leakage current – Drain-Source Leckstrom V <sub>DS</sub> = 25 V	G short I <sub>DSS</sub>			0.5 μA
Gate-Body leakage current – Gate-Substrat Leckstrom V <sub>GS</sub> = 15 V	I <sub>GSS</sub>			10 nA
Gate-Source threshold voltage – Gate-Source Schwellspannung V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 1 mA	V <sub>GS(th)</sub>	0.8 V		3 V
Drain-Source on-state resistance – Drain-Source Einschaltwiderstand V <sub>GS</sub> = 10 V, I <sub>D</sub> = 200 mA	R <sub>DS(on)</sub>			5 Ω
Forward Transconductance – Übertragungssteilheit V <sub>DS</sub> ≥ 2 V <sub>DS(on)</sub> , I <sub>D</sub> = 200 mA	g <sub>FS</sub>		320 mS	
Input Capacitance – Eingangskapazität V <sub>DS</sub> = 10 V, f = 1 MHz	C <sub>iss</sub>		40 pF	
Output Capacitance – Ausgangskapazität V <sub>DS</sub> = 10 V, f = 1 MHz	C <sub>oss</sub>		30 pF	
Reverse Transfer Capacitance – Rückwirkungskapazität V <sub>DS</sub> = 10 V, f = 1 MHz	C <sub>rss</sub>		10 pF	
Turn-On Time – Einschaltzeit V <sub>DD</sub> = 25 V, I <sub>D</sub> = 500 mA, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 50 Ω	t <sub>d(on)</sub>			10 ns
Turn-Off Delay Time – Ausschaltverzögerung V <sub>DD</sub> = 25 V, I <sub>D</sub> = 500 mA, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 50 Ω	t <sub>d(off)</sub>			10 ns